

NCE N-Channel Enhancement Mode Power MOSFET

Description

The NCE30H33LL uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

Application

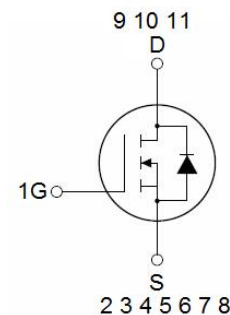
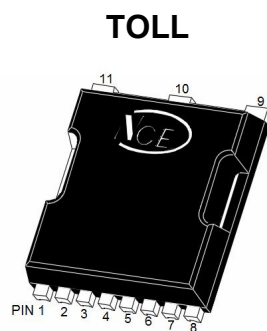
- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

General Features

- $V_{DS} = 30V$, $I_D = 330A$
- $R_{DS(ON)} < 1.5m\Omega$ @ $V_{GS} = 10V$
- $R_{DS(ON)} < 2.4m\Omega$ @ $V_{GS} = 4.5V$
- High density cell design for ultra low R_{dson}
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

100% UIS TESTED!

100% ΔV_{ds} TESTED!



Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCE30H33LL	NCE30H33LL	TOLL	-	-	-

Absolute Maximum Ratings ($T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	330	A
Drain Current-Continuous($T_C = 100^\circ C$)	$I_D(100^\circ C)$	233	A
Pulsed Drain Current	I_{DM}	1280	A
Maximum Power Dissipation	P_D	320	W
Derating factor		2.13	W/ $^\circ C$
Single pulse avalanche energy (Note 5)	E_{AS}	1600	mJ
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 175	$^\circ C$

Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	$R_{\theta JC}$	0.47	$^\circ C/W$
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Electrical Characteristics ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

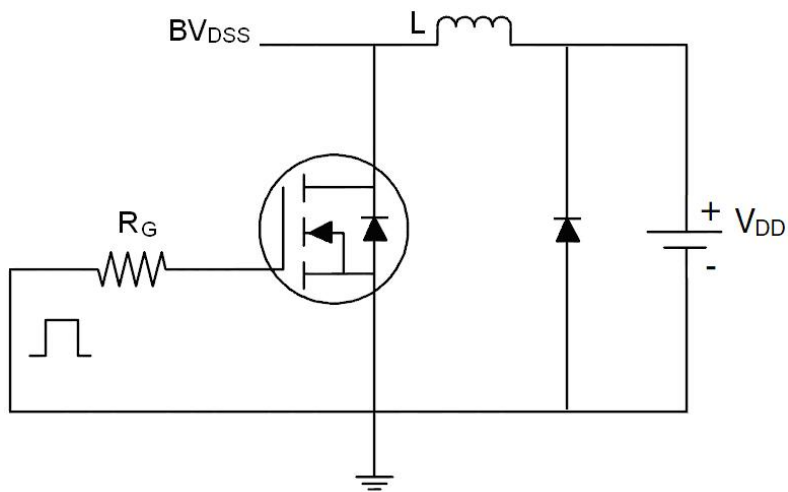
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	30		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1.0	1.6	2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =160A	-	1.1	1.5	mΩ
		V _{GS} =4.5V, I _D =160A	-	1.6	2.4	
Forward Transconductance	g _{FS}	V _{DS} =5V, I _D =160A	50	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, F=1.0MHz	-	13873	-	PF
Output Capacitance	C _{oss}		-	1672	-	PF
Reverse Transfer Capacitance	C _{rss}		-	1508	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}	V _{DD} =15V, R _L =15Ω, R _G =2.5Ω, V _{GS} =10V	-	18	-	nS
Turn-on Rise Time	t _r		-	200	-	nS
Turn-Off Delay Time	t _{d(off)}		-	85	-	nS
Turn-Off Fall Time	t _f		-	125	-	nS
Total Gate Charge	Q _g	I _D =160A, V _{DD} =15V, V _{GS} =10V	-	231	-	nC
Gate-Source Charge	Q _{gs}		-	27.5	-	nC
Gate-Drain Charge	Q _{gd}		-	55	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V, I _S =160A	-	0.85	1.2	V
Diode Forward Current (Note 2)	I _S		-	-	330	A
Reverse Recovery Time	t _{rr}	TJ = 25°C, I _F = 160A	-	70		nS
Reverse Recovery Charge	Q _{rr}	di/dt = 100A/μs(Note3)	-	180		nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

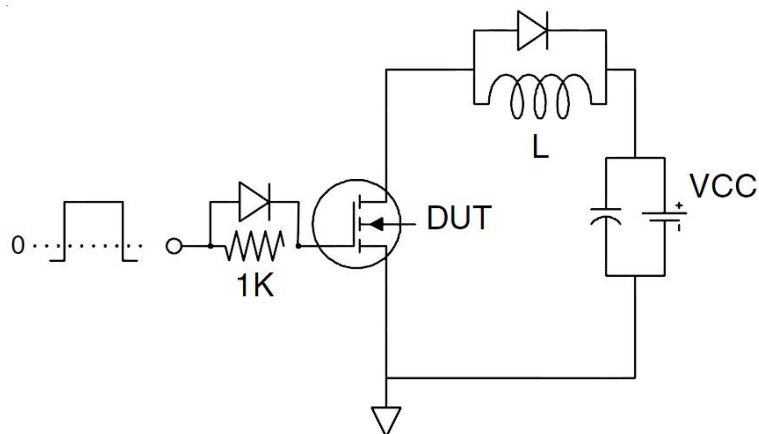
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production
5. EAS condition: $T_J=25^{\circ}\text{C}, V_{DD}=15V, V_G=10V, L=0.5mH, R_G=25\Omega$

Test circuit

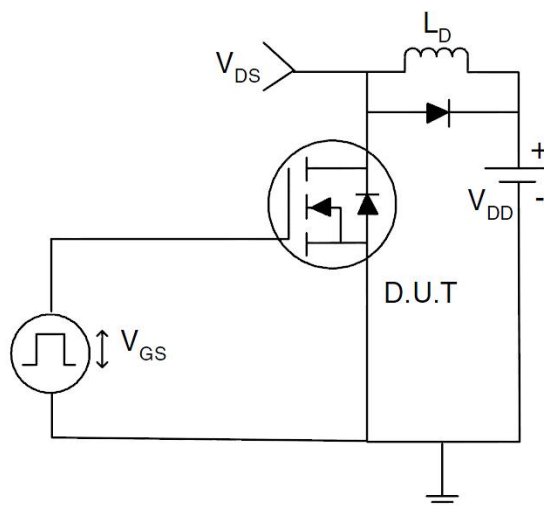
1) E_{AS} test Circuits



2) Gate charge test Circuit:



3) Switch Time Test Circuit:



Typical Electrical and Thermal Characteristics (Curves)

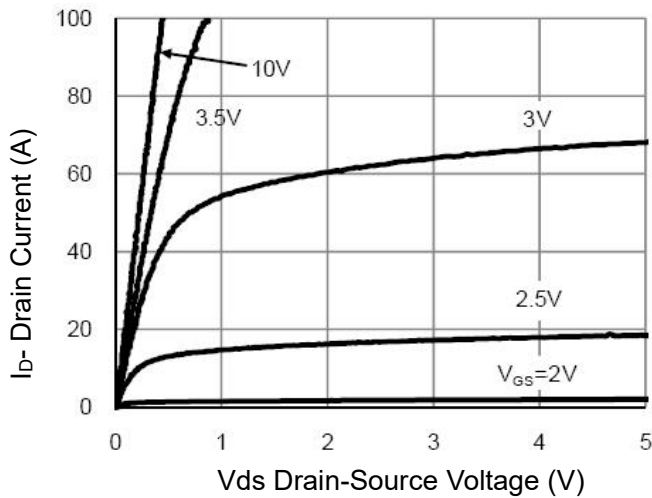


Figure 1 Output Characteristics

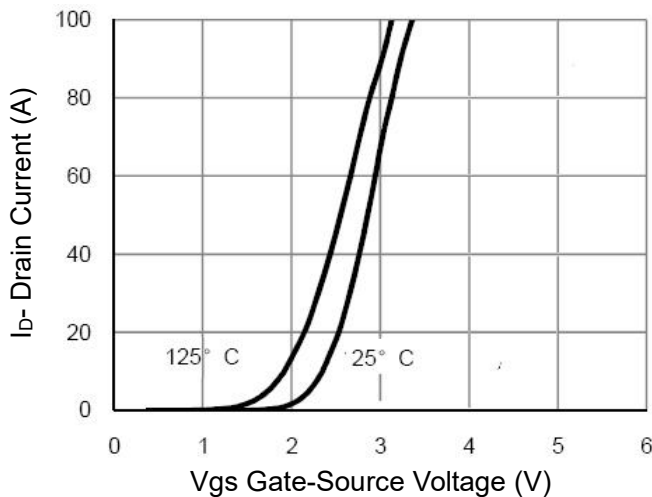


Figure 2 Transfer Characteristics

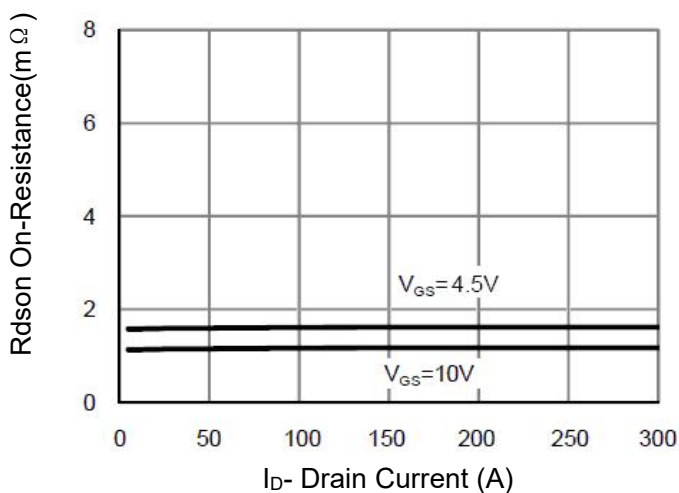


Figure 3 $R_{DS(on)}$ - Drain Current

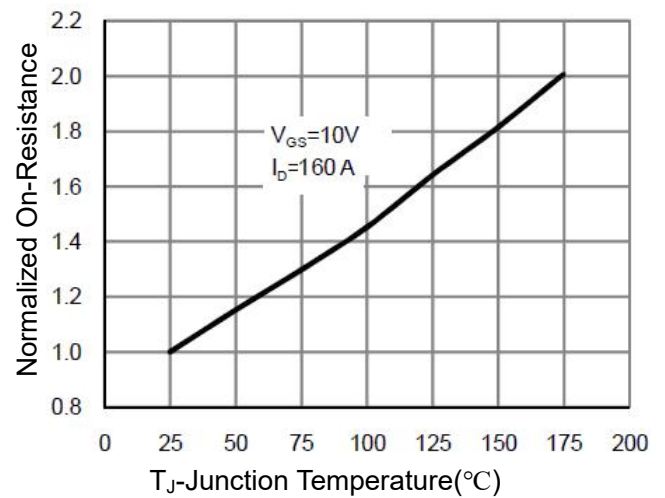


Figure 4 $R_{DS(on)}$ -Junction Temperature

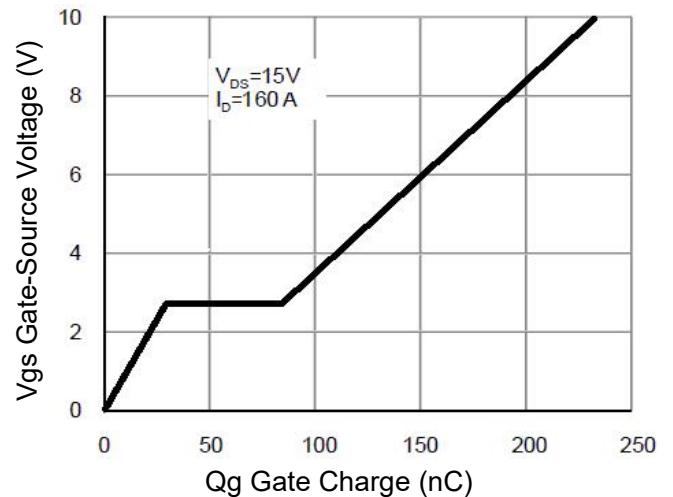


Figure 5 Gate Charge

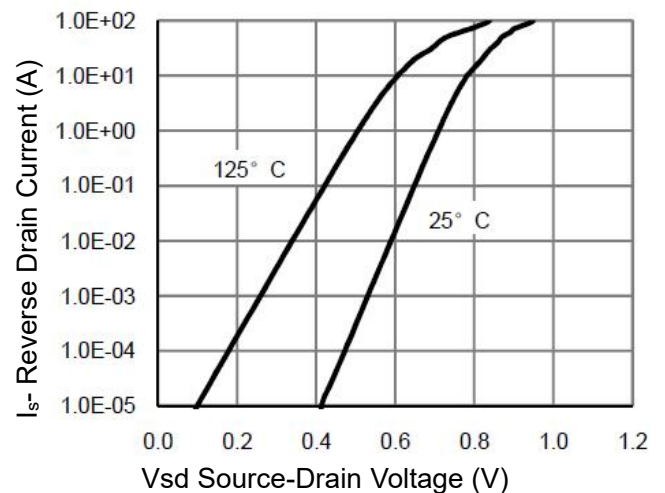


Figure 6 Source- Drain Diode Forward

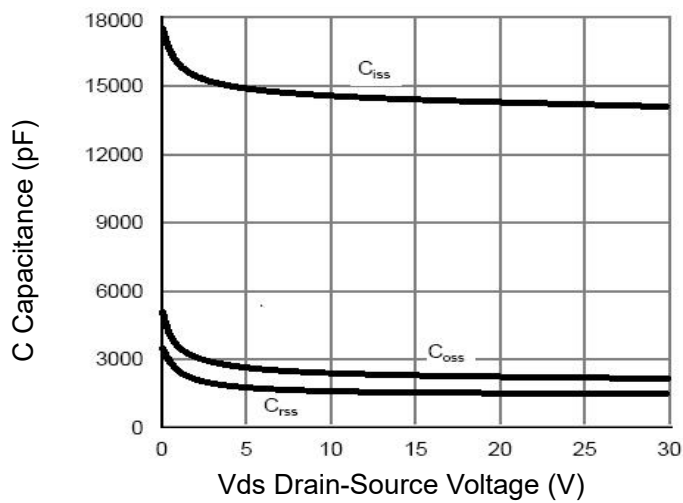


Figure 7 Capacitance vs Vds

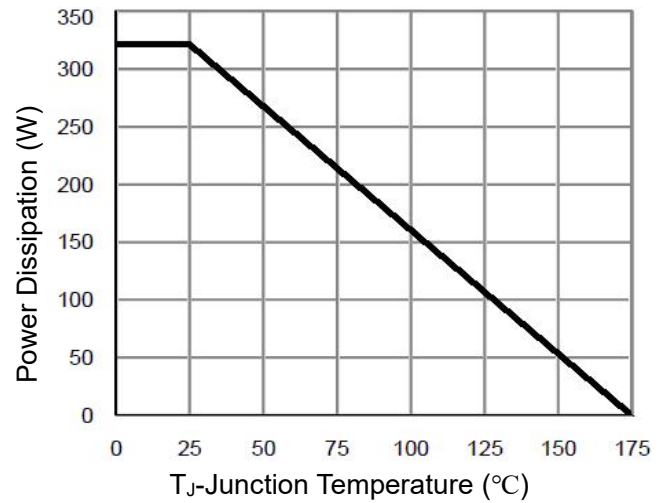


Figure 9 Power De-rating

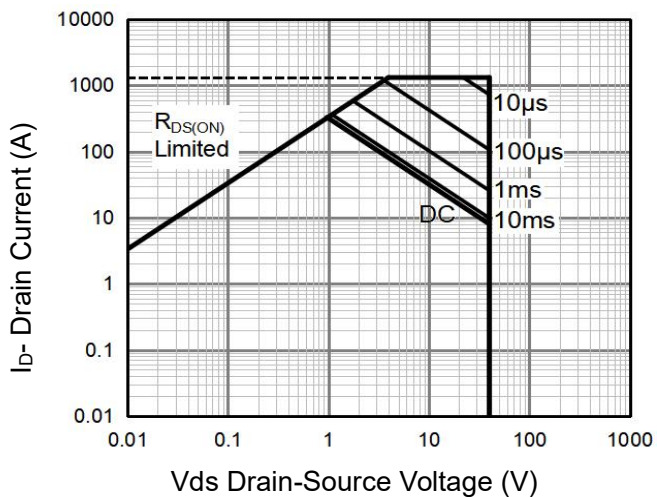


Figure 8 Safe Operation Area

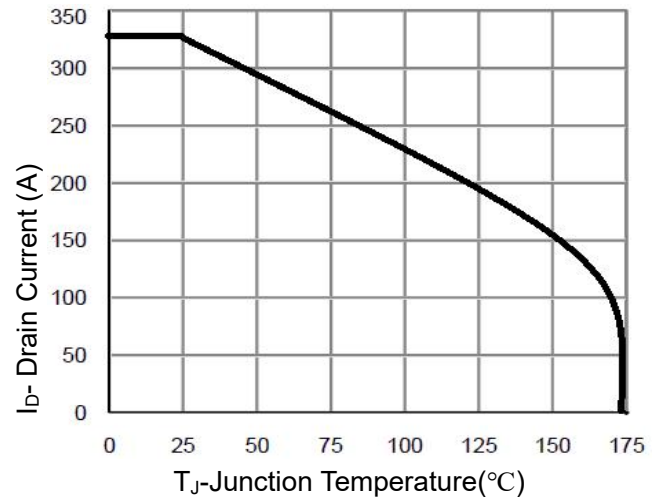


Figure 10 Current vs Junction Temperature

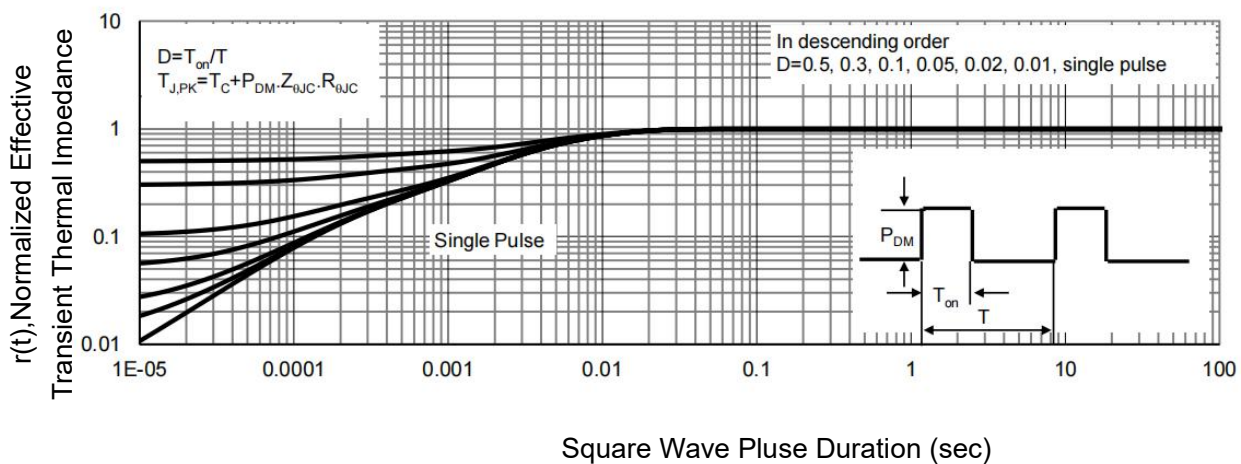
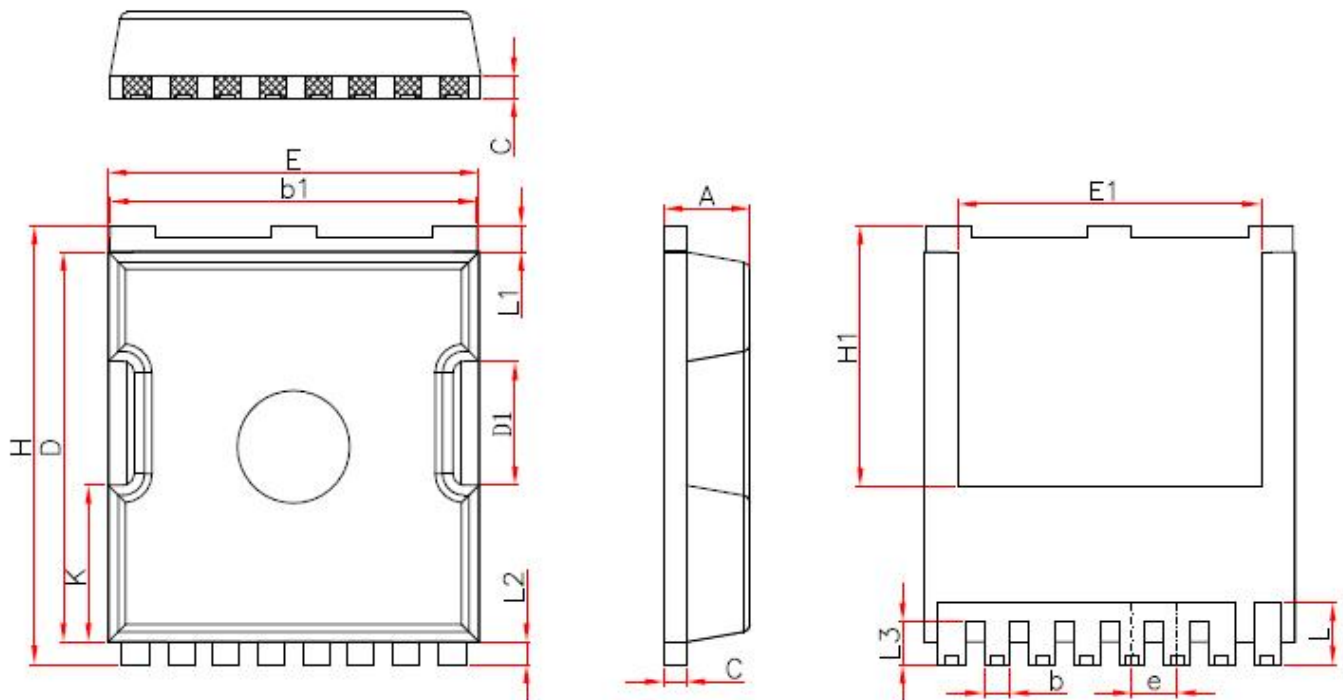


Figure 11 Normalized Maximum Transient Thermal Impedance

TOLL Package Information



Symbol	Millimeters		
	Min.	Nom.	Max.
A	2.20	2.30	2.40
b	0.65	0.75	0.85
b1	9.70	9.80	9.90
C	0.50	0.60	0.70
D	10.30	10.40	10.50
D1	3.15	3.3	3.45
E	9.70	9.90	10.10
E1	8.00	8.10	8.20
e	1.10	1.20	1.30
H	11.6	11.7	11.8
H1	6.85	6.95	7.05
K	4.08	4.18	4.28
L	1.60	1.65	2.10
L1	0.60	0.70	0.80
L2	0.50	0.60	0.70
L3	1.05	1.20	1.30

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